

**Search Notes**

Application/Control No.

10/549,508

Examiner

Taeyoon Kim

Applicant(s)/Patent under  
Reexamination

ALDRIAN, CHRISTINE

Art Unit

1651

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search (USPG-pub;USPAT;USOCR;EPO;JPO;Derwent)	2/25/2009	TK
PubMed/internet (google scholar) search	2/25/2009	TK
Inventor search (PALM)	2/25/2009	TK